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#### **EMC TEST REPORT For FCC**

Test Report No. CTK04-F004

Date of Issue February 25, 2004

Digimax 370 Model/Type No.

Kind of Product Digital Camera

**Applicant** Samsung Techwin Co., Ltd.

**Applicant Address** 145-3 Sangdaewon 1 dong, Chungwon-ku, Sungnam City,

Kyungki-do, Korea

Manufacturer 1) Samsung Techwin Co., Ltd.

2) Tianjin Samsung Opto-Electronics Co., Ltd.

Manufacturer Address : 1) 42, Sungju-dong, Changwon City, Kyungnam, Korea

2) 7 Pingchang Road, Nankai Dist., Tianjin, China

**Contact Person** Kun-Sop, Kim (Manager)

+82-31-740-8253 Telephone

Received Date January 3, 2004

Test period Start: January 28, 2004 End: February 5, 2004

**Test Results** ■ Not in Compliance

The test results presented in this report relate only to the object tested.

CERTITEK Standards Laboratory Co., Ltd. is accredited by Korea Laboratory Accreditation Scheme (KOLAS) which signed the International Laboratory Accreditation Cooperation (ILAC) Mutual Recognition Arrangement (MRA) for the above test item(s) and test method(s).

Tested by

Young-Joon, Park **EMC Test Engineer** 

Date: February 25, 2004

Reviewed by

James Hong

**EMC Technical Manager** 

Date: February 25, 2004

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#### REPORT REVISION HISTORY

Date	Revision	Page No
February 25, 2004	Issued (CTK04-F004)	All
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## 1.0 General Product Description

## 1.0.1 Tested Equipment

		<ul> <li>✓ Unless otherwise indicated, all tests were conducted on Model Digimax 370.</li> <li>✓ Tests performed on Model were considered to be representative of Model(s)</li> </ul>						
1.0.2	Equip	ment Size, Mobility and Identification						
	Dimens Mobility							
	Serial I	No.: Prototype						
1.0.3	Electr	rical Ratings						
		out : 3.3Vdc itput : -						
		or : out : 100-250Vac, 50/60Hz, 0.3A itput : 3.3Vdc, 2.0A						

### 1.0.4 Test Voltage & Frequency (Using the adaptor)

Unless indicated otherwise on the individual data sheet or test results, the test voltage and frequency was as indicated below.

Voltage: 120Vac Frequency: 60Hz

#### 1.0.5 Clock & Other Frequencies Utilized

COACH 6 : 13.5MHz, 27.000MHz TG/CDS/AGC : 49.0909MHz

RTC: 32.768kHz

#### 1.1 Model Differences

Not applicable

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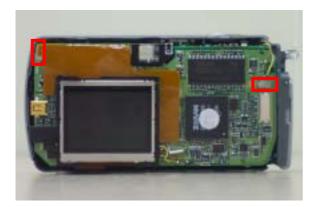


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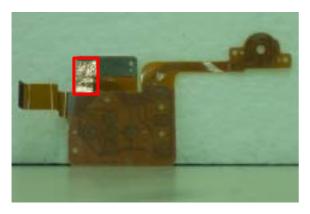


### 1.2 Device Modifications

The following modifications were necessary for compliance:



Gaskets are inserted additionally.



Copper tapes are inserted additionally.

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### 1.3 EUT Configuration(s)

See Appendix A for individual test set-up configuration(s). The following peripheral devices and/or interface cables were connected during the measurement:

Peripheral Devices

Device Manufacturer		Model No.	Serial No.	FCC ID or DoC	
Adaptor	Ault Inc.	PW137KA0300N52	-	-	
Desk Top PC	Hewlett-Packard Company	PD1059P	-	DoC	
Monitor	SAMSUNG	PG17HS	P013H1DN301661	DoC	
Keyboard	SAMSUNG	SEM-DT35	3T011297	DoC	
Mouse (PS/2 type)	SAMSUNG	OMS3CB	0303009873	DoC	
Mouse (USB type)	SAMSUNG	OMS3CB	0303009875	DoC	

□ Cable Description

#	Description	Ferrite Core	Length (m)	Other Details
1	AC power cable, Unshielded	No	1.5	Connect to AC power
2	AC power cable, Unshielded	No	1.8	Connect to AC power
3	AC power cable, Unshielded	No	1.8	Connect to AC power
4	DC output cable, Unshielded	Yes	1.5	Between the EUT and Adaptor
5	USB cable, Shielded	Yes	1.2	Between the EUT and PC
6	Monitor cable, Shielded	Yes	1.8	Between the PC and Monitor
7	Mouse cable, Shielded	No	1.5	PS/2 type
8	Mouse cable, Shielded	No	1.5	USB type
9	Keyboard cable, Shielded	No	1.5	PS/2 type

1.4	Test Software  ☐ Pinging ☐ Not applicable
1.5	<b>EUT Operating Mode(s)</b> Equipment under test was operated during the measurement under the following conditions:
	☐ Test program (H-Pattern) ☐ Test program (color bar) ☐ Standby ☐ Test program (customer specific) ☐ Practice operation : PC mode (Downloading stored images)

## 1.6 Calibration Details of Equipment Used for Measurement

Test equipment and test accessories are calibrated on regular basis. The maximum time between calibrations is one year or what is recommended by the manufacturer, whichever is less. All test equipment calibrations are traceable to the Korea Research Institute of Standards and Science (KRISS), therefore, all test data recorded in this report is traceable to KRISS.

## 1.7 Test Facility

The measurement facility is located at 386-1, Ho-Dong, Yongin-City, Kyungki-Do, Korea 449-100. The sites are constructed in conformance with the requirements of ANSI C63.7, ANSI C63.4 and CISPR Publication 22.

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#### 1.8 **Measurement Procedure**

Preliminary AC power line conducted emissions tests were performed shielded room. To find worst mode, several typical mode and typical cable position were tested. Final AC power line conducted emissions test was performed shielded room. (location is same as Preliminary test)

Based on the preliminary tests of the EUT, final test was proceeded worst case test mode and cable configuration.

Preliminary radiated emissions test were performed anechoic chamber (Distance of antenna and EUT was 3 m). To find worst mode, several typical mode and typical cable position were tested and peak level and frequency were recorded.

Final radiated emissions test was performed Open Area Test Site. Based on the preliminary tests of the EUT, final test was proceeded worst case test mode and cable configuration.

\* Measurement procedures was In accordance with ANSI C63.4-2001 7.2.3, 7.2.4, 8.3.1.1, 8.3.1.2

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# 1.9 Laboratory Accreditations and Listings

Country	Agency	Scope of Accreditation	Logo
USA	FCC	3 and 10 meter Open Area Test Sites to perform FCC Part 15/18 measurements.	FC 93250
JAPAN	VCCI	10 meter Open Area Test Site and one conducted site.	R-948, C-986
KOREA	MIC	EMI (CE, RE) EMS (ESD, Burst, RS, Surge, CS, Power-Frequency Susceptibility, Voltage Dips and Short Interruptions)	No. 51, KR0025
International	KOLAS	EMC	KOLAS MOLAS
Europe	GLAS	EMC EN 55011, EN 55022, EN 55024, EN 61326, EN 50130-4, EN 50081-1, EN 50081-2, EN 50082-1, EN 50082-2, EN 61000-6-2, EN 61000-4-2, EN 61000-4-3, EN 61000-4-4, EN 61000-4-5, EN 61000-4-6, EN 61000-3-2, EN 61000-3-3	<b>TÜV</b> No.13000796-02

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## 2.0 Emissions Test Regulations

The emissions tests were performed according	to following regulations	:
☐ EN 50081-1:1992		
☐ EN 55011:1998 +A1:1999	Group 1 Class A	Group 2 Class B
☐ EN 55013:1990 +A12:1994 +A13:1996 +A ☐ EN 55013:2001	A14:1999	
☐ EN 55014-1:1993 +A1:1997 +A2:1999	<ul><li>☐ Household applianc</li><li>☐ Portable tools</li><li>☐ Semiconductor dev</li></ul>	
☐ EN 55014-1:2000 ☐ EN 55014-2:1997	Sermiconductor dev	1003
☐ EN 55015:1996 +A1:1997 +A2:1999 ☐ EN 55015:2000		
☐ EN 55020:1994 +A11:1996 +A13:1999 +A ☐ EN 55020:1994 +A11:1996 +A12:1999 +A		
☐ EN 55022:1994 +A1:1995 +A2:1997 ☐ EN 55022:1998 +A1:2000	☐ Class A ☐ Class A	☐ Class B ☐ Class B
☐ EN 61000-3-2:1995 +A1:1998 +A2:1998 ☐ EN 61000-3-2:1995 +A1:1998 +A2:1998 ☐ EN 61000-3-2:2000 ☐ EN 61000-3-3:1995	+A14:2000	
☐ VCCI V-3/99.05 : 1999	☐ Class A	☐ Class B
	☐ Class A	⊠ Class B
☐ AS 3548 (1992)	☐ Class A	☐ Class B
□ CISPR 22 (1997)     The unit was tested to CISPR 22 and complied	☐ Class A with the alternate meth	☐ Class B nods allowed by
FCC under paragraphs 15.107 and 15.109.		

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## 2.1 Conducted Voltage Emissions

#### **Test Date**

February 5, 2004

Test Location EMI-CE: Shielded Room	n		
Test Instruments  ☐ Field Strength Meter	er Rohde & Schwarz	ESHS30	828144/002
Test Accessories  ☐ LISN ☐ LISN ☐ Control PC	EMCO EMCO HP	3825/2 3825/2 Vectra 500	
Frequency Range of 150 kHz to 30 MHz 450 kHz to 30 MHz			
Instrument Setting IF Band Width: 9 kHz	<b>j</b> s		
<b>Test Results</b> The requirements are:			
<ul><li>MET</li><li>NOT MET</li><li>NOT APPLICABLE</li></ul>	minimum margin is 5.9 dBu limit exceeded by maximum		

#### Remarks

See Appendix A for test data.

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### 2.2 Radiated Electric Field Emissions

<b>Test Date</b> January 28, 2004			
Test Location  ☑ EMI-OATS: Testing wa  ☐ EMI-OATS: Testing wa			
<b>Test Instruments</b> ☑ Field Strength Meter	Rohde & Schwarz	ESVS30	826638/008
Test Accessories  ☐ ULTRA Broadband Ant ☐ Bi-conical Antenna ☐ Bi-conical Antenna ☐ Log-periodic Antenna  Frequency Range of	Schwarzbeck EMCO EMCO	HL562 BBA9106 3110B 3146	361324/014 41-00201 9607-2564 9607-4567
30 MHz to 1 GHz  Instrument Settings IF Band Width: 120 kHz			
Test Results The requirements are:			
	m margin is 3.14 dBuV/ ceeded by maximum of		

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**Remarks** 

See Appendix A for test data

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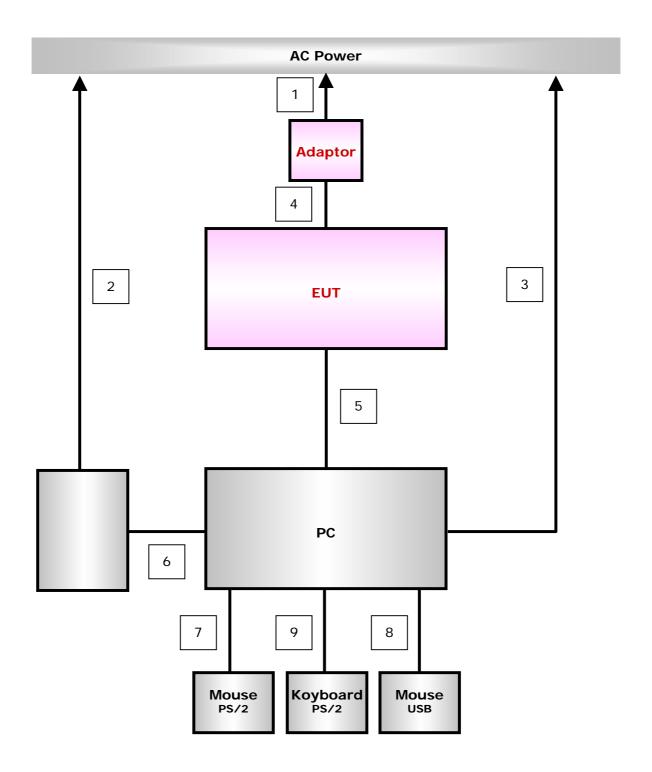
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## Configuration



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#### APPENDIX A - TEST DATA

### **Conducted Voltage Emissions (Quasi-Peak reading)**

Frequency	Correction			ency				Average			
. ,	Fac	ctor	Line	Limit	Reading	Result	Margin	Limit	Reading	Result	Margin
[MHz]	LISN	Cable		[dBuV]	[dBuV]	[dBuV]	[dB]	[dBuV]	[dBuV]	[dBuV]	[dB]
5.77	0.3	0.2	Н	60.0	44.4	44.9	15.1	50.0	43.2	43.7	6.3
5.87	0.3	0.2	Н	60.0	44.6	45.1	14.9	50.0	42.2	42.7	7.3
6.07	0.3	0.2	Н	60.0	44.8	45.3	14.7	50.0	42.8	43.3	6.7
6.17	0.3	0.2	Н	60.0	45.3	45.8	14.2	50.0	43.3	43.8	6.2
6.27	0.3	0.2	Н	60.0	45.2	45.7	14.3	50.0	43.6	44.1	5.9
6.37	0.3	0.2	Н	60.0	45.2	45.7	14.3	50.0	43.3	43.8	6.2
6.47	0.3	0.2	Н	60.0	43.8	44.3	15.7	50.0	41.9	42.4	7.6
6.57	0.3	0.2	Н	60.0	42.6	43.1	16.9	50.0	40.6	41.1	8.9

<sup>\*</sup> If the average limit is met when a quasi-peak detector is used, the EUT shall be deemed to meet both limit and measurement with the average detector is unnecessary.

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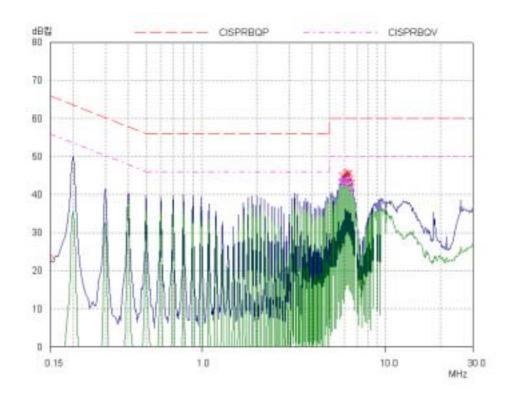
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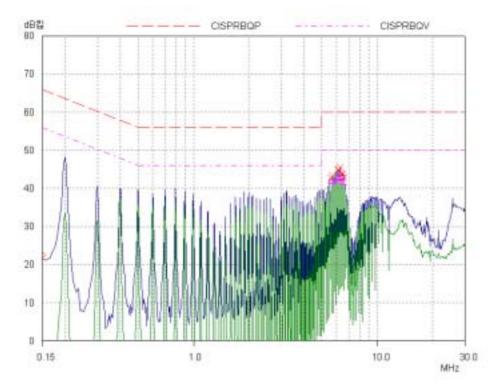
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### Radiated Electric Field Emissions (Quasi-Peak reading)

Frequency	Reading	Pol.	Height	Correction Factor		Limits	Result	Margin
[MHz]	[dBuV/m]		[m]	Antenna	Cable	[dBuV/m]	[dBuV/m]	[dB]
98.21	14.9	V	1.0	9.00	1.90	30.0	25.84	4.16
122.73	12.6	V	1.0	9.55	2.30	30.0	24.45	5.55
147.28	15.9	V	1.0	7.70	2.48	30.0	26.08	3.92
466.01	12.2	Н	1.8	15.00	4.57	37.0	31.80	5.20
627.12	9.7	V	1.3	17.40	5.30	37.0	32.39	4.61
648.04	9.3	V	2.0	17.80	5.50	37.0	32.61	4.39
692.01	8.2	Н	2.2	18.20	5.82	37.0	32.25	4.75
799.21	8.1	Н	4.0	19.50	6.26	37.0	33.86	3.14

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